

**D. J. SANGHVI COLLEGE OF ENGINEERING
DEPARTMENT OF ELECTRONICS ENGINEERING
EXC302: ELECTRONIC DEVICES SEM III
QUIZ 1 SET B SOLUTION**

N.B. :

[Total Marks: 100]

- 1) For every incorrect answer **50% marks** will be deducted.
- 2) While answering the numericals, writing formula is mandatory.

NAME: _____ SAP ID: _____

Given: $n_i = 1 \times 10^{10}/cm^3$, $\epsilon_s = 10^{-12}F/cm$, $\frac{KT}{q} = 0.026V$, $q = 1.6 \times 10^{-19} C$

1. For a BJT in saturation mode, which of the following is true. [02]
 - a) Both the EB and BC junctions are reversed biased
 - b) **Both the EB and BC junctions are forward biased**
 - c) EB junction is forward biased and BC junction is reverse biased.
 - d) EB junction is reverse biased and BC junction is forward biased.

2. How do you bias a BJT to put it into saturation mode and into cutoff mode? Why are these modes useful? [02]
 - ▶ **Bias BJT in saturation mode by forward biasing E-B junction.**
 - ▶ **Bias BJT in cut-off mode by forward biasing B-C junction.**
 - ▶ **BJT can be used as digital logic switches in these modes.**

3. For a BJT operating in forward-active mode, which of the following statements are incorrect? [02]
 - a) $I_C \cong I_B$
 - b) $I_B < I_E$ ✓
 - c) $I_C < I_E$
 - d) $I_E \cong I_c$ ✓
 - e) The width of the Base W_B is much smaller than the minority carrier diffusion length L_p so that the minority carriers survive diffusion through the base. ✓

4. Now consider a pnp BJT in which the base contact is floating (i.e not electrically connected to anything). We put the emitter at 0V and apply a negative voltage V_C to the collector. Which of the following statements are true: [02]
 - a) A very large current flows between the emitter and the collector.
 - b) **A very small current flows between the emitter and the collector.**
 - c) No current flows between the emitter and the collector.
 - d) The B-C junction is forward biased.
 - e) **The B-C junction is reverse biased.**

Explanation: Because there is no current applied at the base, the emitter cannot inject carriers into the base and into the collector. As a result, a large current cannot

flow between the emitter and the collector. However, there will still be current running through the BJT because the minority carriers between the B-C junction will be able to move across the junction due to the reverse bias.

5. You have a silicon pnp bipolar junction transistor in which you measure a base current of $20\mu\text{A}$ when the collector current is 4mA in forward-active mode.
- a) What is the emitter current? [01]
 i_E (in mA): **4.02 mA**
- b) What is the common emitter current gain of the transistor? [01]
 $\beta = \frac{I_C}{I_B} = \mathbf{200}$
- b) What is the common base current gain of the transistor? [01]
 $\alpha = \frac{I_C}{I_B} = \mathbf{0.995}$
6. How are the PN junctions biased in the forward-active region of a pnp BJT? [02]
- a) **E-B: forward biased B-C: reverse biased**
b) E-B: forward biased B-C: forward biased
c) E-B: reverse biased B-C: reverse biased
d) E-B: reverse biased B-C: forward biased
7. Which of the following would be considered as a good value of β ? [02]
- a) 0.099
b) 0.99
c) 1.5
d) 5
e) **200**
8. Which of the following would be considered as a good value of α ? [02]
- a) 0.099
b) **0.99**
c) 1.5
d) 5
e) 200

9. Which of the following would be considered as a good value of emitter injection efficiency (γ) w.r.t BJT ? [02]
- 0.099
 - 0.99**
 - 1.5
 - 5
 - 200
10. Which of the following is the definition of the emitter injection efficiency γ of an NPN BJT ? [02]
- $\gamma = I_{CN} / (I_{EN})$
 - $\gamma = I_{CP} / (I_{EP})$
 - $\gamma = I_{EP} / (I_{EP} + I_{EN})$
 - $\gamma = I_{EN} / (I_{EP} + I_{EN})$ ✓
11. Which of the following is the definition of the base transport factor b or α_T of an NPN BJT ? [02]
- $\alpha_T = I_{CN} / (I_{EN})$ ✓
 - $\alpha_T = I_{CP} / (I_{EP})$
 - $\alpha_T = I_{EP} / (I_{EP} + I_{EN})$
 - $\alpha_T = I_{EN} / (I_{EP} + I_{EN})$
12. What is the order of highest doping, next highest doping and lightest doping in a BJT? [02]
- Collector,base,emitter
 - Emitter,base,collector**
 - Emitter,collector,base
 - Base,collector,emitter
13. How is the transconductance of a transistor defined ? [02]
- The change in output current divided by the change in output voltage.
 - The change in input current divided by the change in input voltage.
 - The change in output voltage divided by the change in output current.
 - The change in output current divided by the change in input voltage.**

14. Which two of the following would increase the emitter injection efficiency ? [02]

- a) **Increasing the emitter doping**
- b) Increasing the base doping
- c) Decreasing the collector doping
- d) Decreasing the emitter doping

15. Derive the relation: $\alpha = \beta/(1 + \beta)$ [02]

$$I_E = I_C + I_B \quad \alpha = \frac{I_C}{I_E}$$

$$I_B = I_E - I_C$$

$$I_B = I_E - \beta I_B \quad I_C = \beta I_B$$

$$I_B(1 + \beta) = I_E$$

$$I_B(1 + \beta) = \frac{I_C}{\alpha}$$

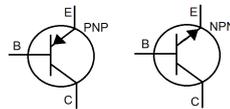
$$\alpha = \frac{I_C}{I_B(1 + \beta)} = \frac{\beta}{1 + \beta}$$

16. Which of the following are Non-ideal effects in BJT ? [01]

- a) **Base width modulation.**
- b) Constant energy band-gap.
- c) Low level injection.
- d) **Non-uniform base doping.**
- e) **High level injection.**

17. Draw the symbol of following : [02]

- a) NPN BJT



- b) PNP BJT

- c) PN diode



- d) Zener diode



18. In ED lab, you have performed experiment on Zener as voltage regulator ? [02]

a) What was the definition of line regulation

Line regulation: It is a measure of ability of the output voltage to remain constant irrespective of the variations in line voltages.

B) What was the formula of load regulation

$$\% \text{ Load regulation} = \left(\frac{V_{NL} - V_{FL}}{V_{NL}} \right) \times 100$$

19. In ED lab, you have performed experiment on npn BJT input I-V and output I-V characteristics in common emitter configuration ? [02]

Plot those input and output I-V characteristics.

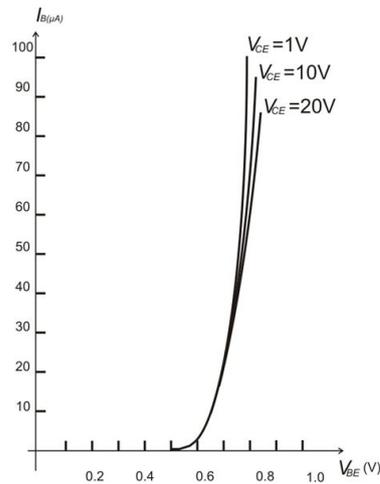


Figure 1: Input Characteristics

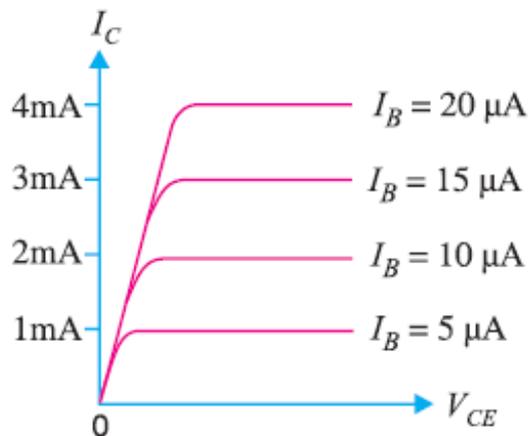


Figure 2: Output Characteristics

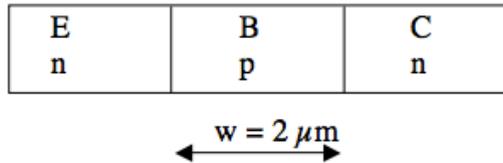
20. Consider a Silicon npn BJT with the following doping levels:

$$\text{Emitter } N_{D,E} = 10^{18} \text{ cm}^{-3}$$

$$\text{Base } N_{A,B} = 10^{15} \text{ cm}^{-3}$$

$$\text{Collector } N_{D,C} = 10^{15} \text{ cm}^{-3}$$

Note that B and C have the same doping level. The width W of the p-type base region is $2\mu\text{m}$, as shown on the diagram.



1. Which junction has the larger depletion region? [02]

- The emitter-base junction has the larger depletion region.
- The base-collector junction has the larger depletion region.**
- The depletion regions are of equal size.
- We don't have enough information to determine which depletion region is larger.

2. What is the width of the B-C depletion region in the unbiased case? [02]

(Please use $n_i = 1 \times 10^{10} / \text{cm}^3$ for the intrinsic carrier concentration of Si.)

$$V_{bi} = \frac{KT}{q} \ln \left(\frac{N_{A,B} N_{D,C}}{n_i^2} \right) = \mathbf{0.598 \text{ V}}$$

$$W_{A,B} = \sqrt{\frac{2\epsilon_s V_{bi}}{q} \left(\frac{N_{A,B} + N_{D,C}}{N_{A,B} N_{D,C}} \right)} = \mathbf{1.22 \times 10^{-4} \text{ cm}}$$

3. Suppose we reverse bias the BC junction by applying 5V. What is the width of the B-C depletion region? [02]

$$W_{A,B} = \sqrt{\frac{2\epsilon_s (V_{bi} + V_R)}{q} \left(\frac{N_{A,B} + N_{D,C}}{N_{A,B} N_{D,C}} \right)} = \mathbf{3.74 \times 10^{-4} \text{ cm}}$$

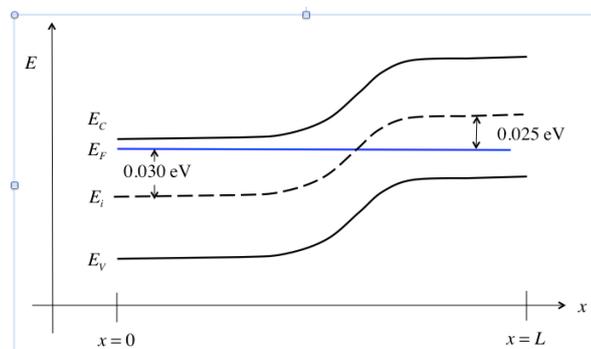
21. What does p_{no} mean ? [01]

- Equilibrium electron concentration in p-type semiconductor.
- Equilibrium hole concentration in p-type semiconductor.
- Equilibrium hole concentration in n-type semiconductor.**
- Equilibrium electron concentration in n-type semiconductor.
- Equilibrium electron concentration

22. Which of the following statements is true about the magnitude of the electric field in the transition region of a PN junction ? [01]

- a) It is constant in space.
- b) **It first decreases linearly, reaches a peak at the junction, then increases linearly.**
- c) It first increases linearly, reaches a peak at the junction, then decreases linearly.
- d) It increases linearly from the N side to the P side.
- e) It decreases linearly from the N side to the P side.

23. For the energy band diagram below, answer the following questions.



a) Is the potential at $x = 0$ more or less positive than the potential at $x = L$? [02]
Explain your answer.

A positive potential lowers the bands. At $x = 0$, E_C is lower than at $x = L$, so **the potential at $x = 0$ must be more positive than the potential at $x = L$**

b) What is the magnitude of the built-in potential? [02]

From the energy band diagram, the amount of band bending is the potential barrier V_{bi}

$$qV_{bi} = 0.03 \text{ eV} + 0.025 \text{ eV}$$

$$V_{bi} = 0.03 \text{ V} + 0.025 \text{ V}$$

$$V_{bi} = \mathbf{0.055 \text{ V}}$$

24. For a Si pn homojunction $N_A = 10^{18}/\text{cm}^3$ and $N_D = 10^{17}/\text{cm}^3$ at $T=300\text{K}$.

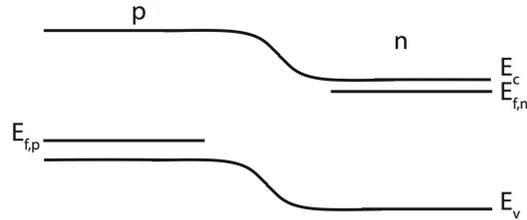
a) Calculate the built-in potential for the junction. [02]

$$V_{bi} = \frac{KT}{q} \ln \left(\frac{N_A N_D}{n_i^2} \right) = \mathbf{0.89 \text{ V}}$$

b) Now calculate the depletion region width (in μm) for the junction. [02]

$$W = \sqrt{\frac{2\epsilon_s V_{bi}}{q} \left(\frac{N_A + N_D}{N_A N_D} \right)} = 1.1 \times 10^{-5} \text{ cm} = \mathbf{0.11 \mu\text{m}}$$

25. Consider the band diagram shown below, and then answer the following questions:



a) Is the semiconductor at equilibrium ? [02]

If yes, explain why ?

If no, explain why ?

Answer: No, because fermi level is not flat throughout the semiconductor.

b) What is the direction of electron diffusion ? [02]

The electrons diffuse from left to right

The electrons diffuse from right to left

There is no net electron diffusion current

c) What is the direction of electron drift? [02]

The electrons drift from left to right

The electrons drift from right to left

There is no net electron drift current

d) What is the direction of hole diffusion? [02]

The holes diffuse from left to right

The holes diffuse from right to left

There is no net hole diffusion current

e) What is the direction of hole drift? [02]

The holes drift from left to right

The holes drift from right to left

There is no net hole drift current

Explanation: 1. Carriers diffuse from areas of high concentration to areas of low concentration. 2. Electrons drift down the band. 3. Holes drift up the band.

26. You have a Si pn junction diode at room temperature with $N_A = 10^{19}/cm^3$ and $N_D = 10^{18}/cm^3$. (You may assume the following carrier mobilities for Silicon: $\mu_p = 70cm^2/Vs$ and $\mu_n = 250cm^2/Vs$. You may also assume a minority carrier lifetime of $\tau_n = \tau_p = 10^{-8}s$ for both electrons and holes, and $n_i = 10^{10}cm^{-3}$.)

a) What is the diffusivity of the holes in the Silicon? [01]

$$D_p \text{ (in } cm^2/s\text{): } \mathbf{1.82}$$

$$D_p = V_T \mu_p = 1.82 \text{ } cm^2/s$$

b) What is the diffusivity of the electrons in the Silicon? [01]

$$D_n \text{ (in } cm^2/s\text{): } \mathbf{6.5}$$

$$D_n = V_T \mu_n = 6.5 \text{ } cm^2/s$$

c) What is the minority carrier diffusion length for holes? [01]

$$L_p \text{ (in } cm\text{): } \mathbf{1.34} \times 10^{-4}$$

$$L_P = \sqrt{D_P \tau_p} = 1.34 \times 10^{-4} \text{ } cm$$

d) What is the minority carrier diffusion length for electrons? [01]

$$L_n \text{ (in } cm\text{): } \mathbf{2.55} \times 10^{-4}$$

$$L_N = \sqrt{D_N \tau_n} = 2.55 \times 10^{-4} \text{ } cm$$

e) Calculate J_0 for the diode described above? [02]

$$J_0 \text{ (in } A/cm^2\text{): } \mathbf{2.58} \times 10^{-13}$$

$$J = q \left[\frac{D_P}{L_P} p_{n0} + \frac{D_N}{L_N} n_{p0} \right] = 2.58 \times 10^{-13} A/cm^2$$

f) Use the ideal diode equation to predict the current density when a forward bias of 0.45V is applied to the diode? [02]

$$J \text{ (in } A/cm^2\text{): } \mathbf{8.477} \times 10^{-6}$$

$$J = J_0 \left(e^{\frac{V_A}{V_T}} - 1 \right) = 8.477 \times 10^{-6} A/cm^2$$

g) Use the ideal diode equation to predict the current density when a reverse bias of -10V is applied to the diode? [02]

$$J \text{ (in } A/cm^2\text{): } \mathbf{-2.58} \times 10^{-13}$$

$$J = J_0 \left(e^{\frac{V_R}{V_T}} - 1 \right) = -2.58 \times 10^{-13} A/cm^2$$

27. Indicate whether the following applied voltages produce a forward- or a reverse-biased p-n junction: [02]

a) Positive voltage is applied to the p-side: **Forward bias**

b) Negative voltage is applied to the p-side: **Reverse bias**

c) Positive voltage is applied to the n-side: **Reverse bias**

d) Negative voltage is applied to the n-side: **Forward bias**

28. Calculate the current through a silicon diode at room temperature for the following cases. Assume $I_0 = 2 \times 10^{-13}$ A.

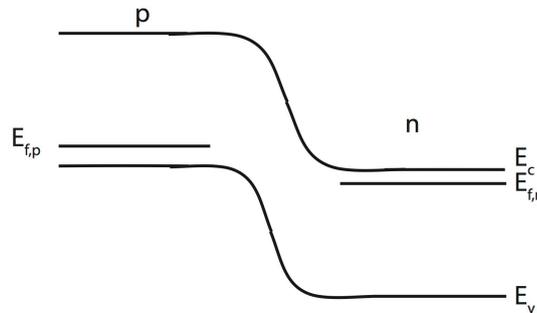
a) When a voltage of +0.3V is applied to the p-side of the junction. [01]

$$I = I_0 \left(e^{\frac{V_A}{V_T}} - 1 \right) = \mathbf{0.0205 \times 10^{-6} \text{ A}}$$

a) When a voltage of -10V is applied to the p-side of the junction. [01]

$$I = I_0 \left(e^{\frac{V_R}{V_T}} - 1 \right) = \mathbf{- 2 \times 10^{-13} \text{ A}}$$

29. Consider the band diagram shown below, and then answer the following questions:



What is the band diagram representing ? [02]

- a) Forward-bias case.
- b) **Reverse-bias case.**
- c) Un-biased case.

30. What is the physical meaning of the area under $E(x)$ vs x in a pn junction ? (Note $E(x)$ is the Electric field as a function of distance x) [02]

- a) It is the total doping density in the depletion region.
- b) It is equal to the band-gap of the semiconductor.
- c) It is the net space-charge density in the depletion region.
- d) **It is the built-in potential of the junction.**

31. A Si diode is symmetrically doped at $N_A = N_D = 10^{16} \text{ cm}^{-3}$. Answer the following questions assuming room temperature, equilibrium conditions and the depletion approximation.

Compute V_{bi} [02]

$$V_{bi} = \frac{KT}{q} \ln \left(\frac{N_A N_D}{n_i^2} \right) = \mathbf{0.718 \text{ V}}$$

Compute x_n , x_p and W

[04]

$$W = \sqrt{\frac{2\epsilon_s V_{bi}}{q} \left(\frac{N_A + N_D}{N_A N_D} \right)} = 4.236 \times 10^{-5} \text{ cm}$$

$$x_N = \left(\frac{N_A}{N_A + N_D} \right) W = 2.12 \times 10^{-5} \text{ cm}$$

$$x_P = \left(\frac{N_D}{N_A + N_D} \right) W = 2.12 \times 10^{-5} \text{ cm}$$

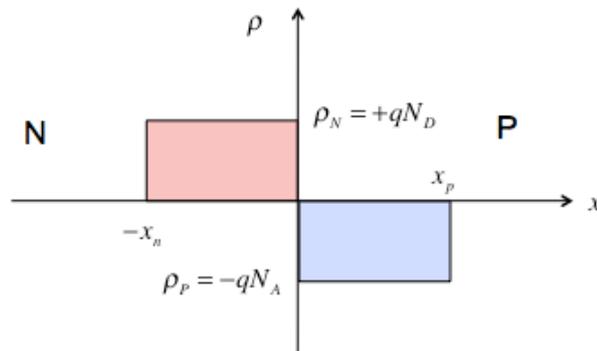
Compute $E(x=0)$

[02]

$$E(x=0) = -\frac{2V_{bi}}{W} = -33.899 \times 10^3 \text{ V/cm}$$

Sketch $\rho(x)$ vs. x

[02]



32. Which of the following is true about impact ionization ?

[02]

- a) It is the cause of avalanche breakdown.
- b) It can be initiated by either electrons or holes.
- c) It generates both electrons and holes.
- d) **All of the above.**
- e) None of the above.

33. What effect does quantum mechanical tunneling have on a PN junction ?

[02]

- a) It can lead to reverse breakdown at low voltages.
- b) It is the cause for zener breakdown.
- c) It occurs in a heavily doped diode.
- d) **All of the above.**
- e) None of the above.

34. Which of the following is true about the small signal model of a PN junction ? [02]
- a) It consists of a resistor in series with a capacitor.
 - b) **It consists of a resistor in parallel with a capacitor.**
 - c) It consists of a resistor in series with an inductor.
 - d) It consists of a resistor in parallel with an inductor.
35. Which of the following is true about the diffusion resistance in the small signal model of a PN junction diode ? [02]
- a) It has very large value in reverse bias and a very small value in forward bias.
 - b) It is equal to $(dI_D/dV_A)^{-1}$
 - c) In forward bias, it is very close to (V_T/I_D)
 - d) **All of the above.**
 - e) None of the above.
